

<i>Notice of References Cited</i>		Application/Control No. 10/782,863	Applicant(s)/Patent Under Reexamination SANDSTROM ET AL.	
		Examiner PHALLAKA KIK	Art Unit 2825	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,496,160 B1	12-2002	Tanner et al.	345/3.1
*	C	US-7,469,058 B2	12-2008	Latypov et al.	382/144
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	W	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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